

UNISONIC TECHNOLOGIES CO., LTD

3NM95Z-Q Preliminary Power MOSFET

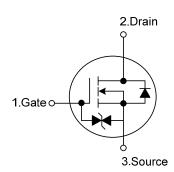
3.0A, 950V N-CHANNEL POWER MOSFET

■ DESCRIPTION

The UTC **3NM95Z-Q** is a high voltage power MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient AC to DC converters and bridge circuits.

■ FEATURES

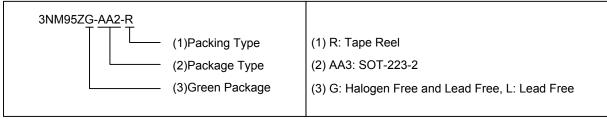
- * $R_{DS(ON)} \le 3.8 \Omega @ V_{GS} = 10V, I_D = 1.5A$
- * High Switching Speed
- SYMBOL



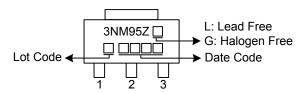
ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
3NM95ZL-AA2-R	3NM95ZG-AA2-R	SOT-223-2	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



MARKING



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■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	950	V	
Gate-Source Voltage		V_{GSS}	±20	V	
Drain Current	Continuous	I_D	3	Α	
	Pulsed (Note 2)	I _{DM}	6	Α	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	32	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	1.4	V/ns	
Power Dissipation		P_D	1.9	W	
Junction Temperature		T_J	+150	°C	
Storage Temperature		T_{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=100mH, I_{AS} =0.8A, V_{DD} =50V, R_{G} =25 Ω , Starting T_{J} = 25 $^{\circ}$ C
- 4. $I_{SD} \le 3.0A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	150	°C/W	
Junction to Case	θ_{JC}	65.7	°C/W	

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

■ ELECTRICAL CHARACTERISTICS (T_J = 25°C, unless otherwise specified)

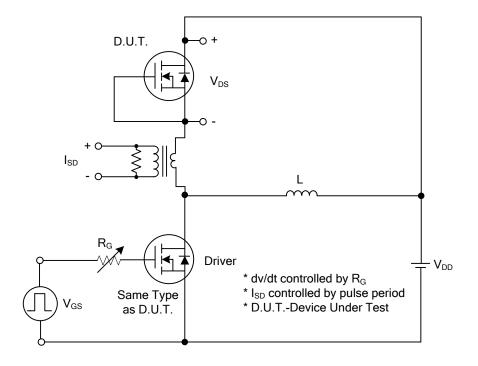
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS					ā.	ā.	
Drain-Source Breakdown Voltage		BV_{DSS}	V_{GS} =0V, I_D = 250 μ A	950			V
Drain-Source Leakage Current		I_{DSS}	V _{DS} =950V, V _{GS} =0V			10	μΑ
Gate-Source Leakage Current	Forward	I _{GSS}	V_{GS} =20V, V_{DS} =0V			10	μΑ
	Reverse		V _{GS} =-20V, V _{DS} =0V			-10	μΑ
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	2.5		4.5	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =1.5A			3.8	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance	put Capacitance				225		pF
Output Capacitance		Coss	V _{GS} =0V, V _{DS} =50V, f=1.0 MHz		30		pF
Reverse Transfer Capacitance		C _{RSS}			2		pF
SWITCHING CHARACTERISTICS	3						
Total Gate Charge (Note 1)		Q_G	-\/ -760\/ \/ -10\/		16		nC
Gateource Charge		Q_GS	V_{DS} =760V, V_{GS} =10V, I_{D} =3.0A, I_{G} =1mA (Note 1, 2)		5.5		nC
Gate-Drain Charge		Q_GD	ID-3.0A, IG-IIIIA (Note 1, 2)		3.4		nC
Turn-on Delay Time (Note 1)		$t_{D(ON)}$			5		ns
Rise Time		t_{R}	V _{DS} =100V, V _{GS} =10V,		18		ns
Turn-off Delay Time		t _{D(OFF)}	I_D =3.0A, R_G =25 Ω (Note 1, 2)		38		ns
Fall-Time		t_{F}			32		ns
SOURCE- DRAIN DIODE RATING	S AND CH	ARACTERIS [*]	TICS				
Maximum Body-Diode Continuous Current		Is				3	Α
Maximum Body-Diode Pulsed Current		I _{SM}				6	Α
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =3.0A, V _{GS} =0V			1.4	V
Reverse Recovery Time (Note 1)		t _{rr}	I _S =3.0A, V _{GS} =0V 36		365		ns
Reverse Recovery Charge		Qrr	dI _F /dt=100A/µs (Note1)		2.5		μC

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

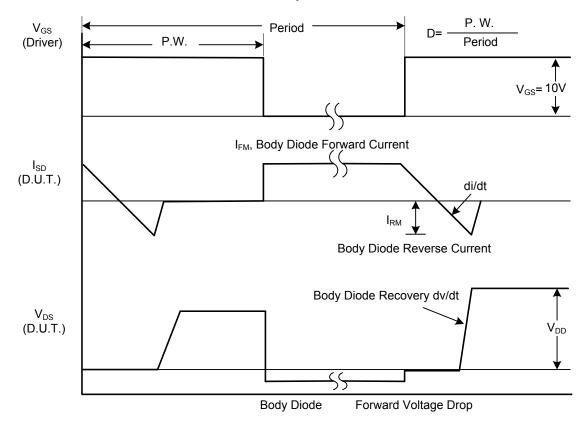
2. Essentially independent of operating temperature.



TEST CIRCUITS AND WAVEFORMS

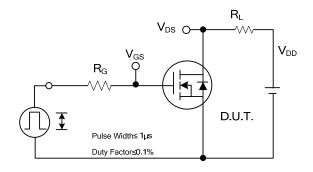


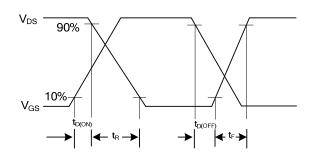
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

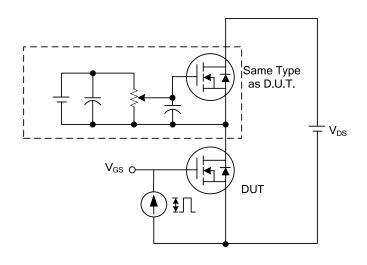
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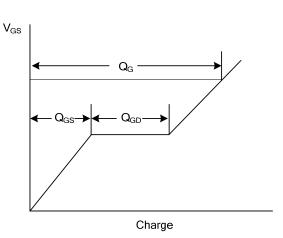




Switching Test Circuit

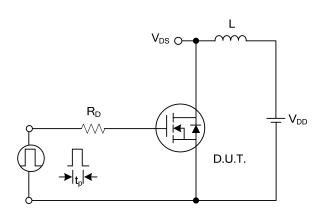
Switching Waveforms

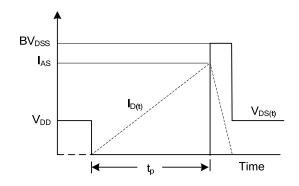




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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